

# Simulation Study for CEPC Fast Luminosity Detector based on 4H-SiC

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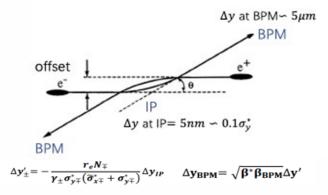
# **OUTLINE**

- ➤ Description for CEPC Fast Luminosity Monitor System
- ➤ Introduction for 4H-SiC detector
- ➤ Simulation Discussion for CEPC Fast Luminosity Detector
- ➤ Beam-Beam Deflection and Background Concerns for CEPC Fast Luminosity Detector
- ➤ Conclusion and Next to do

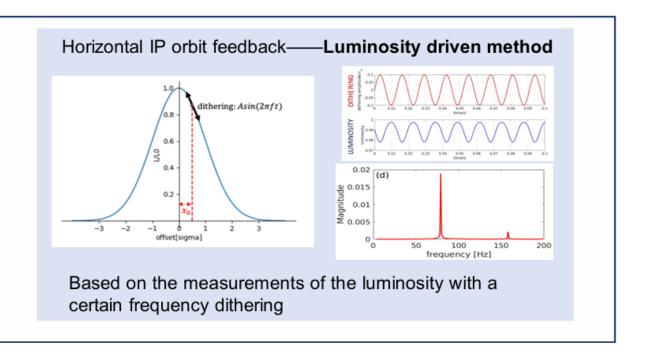
## Description for CEPC Fast Luminosity Monitor System

- Crab-waist scheme for CEPC to achieve high luminosity
  - Beam size very small (horizontal:  $14 \mu m$ ; vertical: 36 nm)
  - Luminosity sensitive to the stability of beam jitter(like ground motion)
- Orbit feedback system at IP to maintain an optimum collision and maximize the luminosity
- Two possible methods for IP orbit feedback system

Vertical IP orbit feedback——Beam-beam deflection driven method

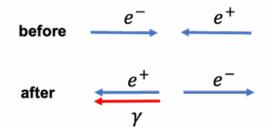


Based on the measurement of the offset with BPMs upstream and downstream of the IP



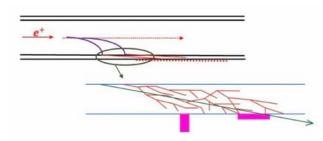
# Description for CEPC Fast Luminosity Monitor System

- The fast luminosity monitor based on radiative Bhabha at vanishing photon degree
  - Very large cross section (127mbarn)
  - Bhabha particles produced at the IP are proportional to the luminosity

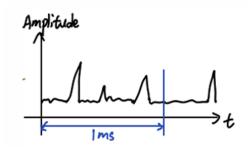


Luminosity	Cross section	Number of Bhabha	Aimed precision	Required fraction
5 ×10 <sup>34</sup>	0.127 barn	$6.35 \times 10^6$ in 1ms	2% in 1ms	4×10 <sup>-4</sup>

• The low energy Bhabha electrons hit the beam pipe downstream of IP



• The detectors put outside the beam pipe to capture secondary particles and provide the luminosity information

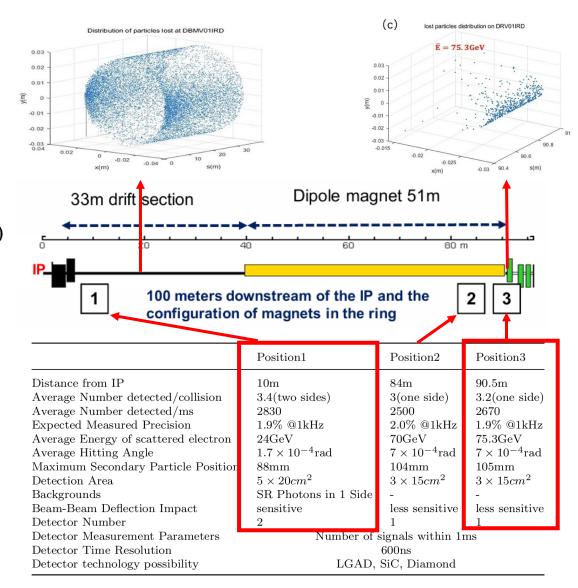


$$N = \sigma \times \mathcal{L} \times \tau \times \epsilon$$
  $v = \frac{1}{\sqrt{N}}$ 

## Description for CEPC Fast Luminosity Monitor System

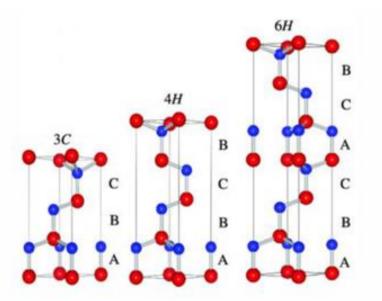
#### Downstream of IP 100 m :

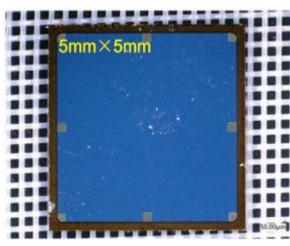
- 3 quadrupoles (strong defocusing in the horizontal direction)
- 33 m drift section (some low-energy electrons are likely to be lost)
- 51 m dipole magnet (deflects electrons towards inner side)
- Additional drift sections, magnets and other elements....
- Detector installed position:
  - Position 1 and Position 3
  - Position 2 inside the dipole magnet (spatial constraints)

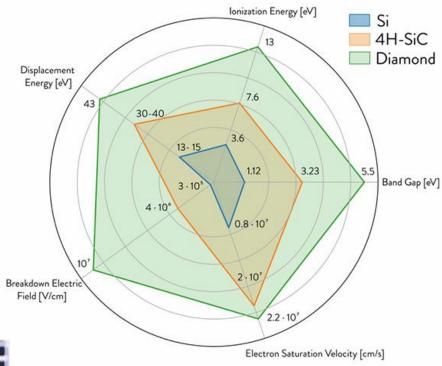


#### Introduction for 4H-SiC detector

- Wide bandgap semiconductor (3.26 eV)
  - low leakage current
  - insensitivity to visible light
  - high breakdown field and saturation velocity
  - potentially higher radiation hardness, no cooling needed
  - high ionization energy
  - limitations in epitaxial layer thickness and resistivity
- Material not new but now available in higher quality (MOS technologies)

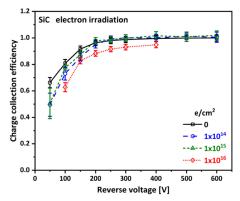


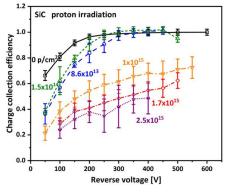


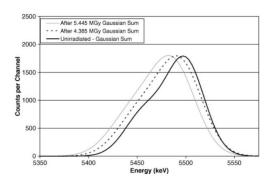


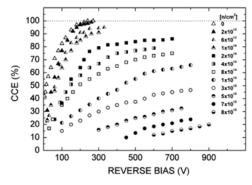
#### Introduction for 4H-SiC detector

- Under 5.445 MGy gamma irradiation:
  - The full width at half maximum (FWHM) of the peak increased by 17%
  - The energy shifted by 0.24% relative to the unirradiated detector for the 238Pu alpha source.
  - Both of these changes are negligible
- Electron irradiation at 2 MeV:
  - $1 \times 10^{16}$  e/cm<sup>2</sup>: CCE decreases to 90%
- Neutron irradiation at 1 MeV:
  - $1 \times 10^{15}$  n/cm<sup>2</sup>: the diodes maintain the charge collection efficiency (CCE) of 80%
  - $8 \times 10^{15} \,\text{n/cm}^2$ : CCE decreases to 20%
- Proton irradiation at 24 GeV:
  - $2.5 \times 10^{15}$  p/cm<sup>2</sup>: CCE decreases to 45%
- X-ray irradiation indicate that an irradiation dose of 1 MGy does not affect the performance of the 4H-SiC detector.[Poster D01]







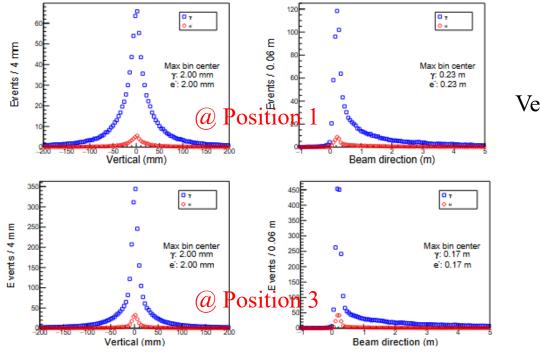


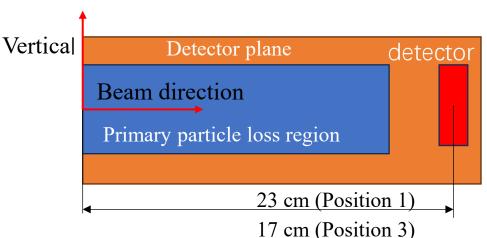
[1]F.H. Ruddy and J.G. Seidel, The effects of intense gamma-irradiation on the alpha-particle response of silicon carbide semiconductor radiation detectors, Nuclear Instruments and Methods in Physics Research Section B: Beam Interactions with Materials and Atoms 263 (2007) 163.

[2]F. Nava, A. Castaldini, A. Cavallini, P. Errani and V. Cindro, Radiation Detection properties of 4H-SiC Schottky Diodes Irradiated up to 10<sup>16</sup>n/cm<sup>2</sup> by 1 MeV Neutrons, IEEE Transactions on 369 Nuclear Science 53 (2006) 2977.370

[3]J.M. Raff, G. Pellegrini, P. Godignon, S.O. Ugobono, G. Rius, I. Tsunoda et al., Electron, Neutron,371 and Proton Irradiation Effects on SiC Radiation Detectors, IEEE Transactions on Nuclear Science 67372(2020) 72481.373

- Secondary particle:
  - Generated by the interaction between primary electrons and beam pipe
  - Captured by the detector and generates a signal
  - Photons dominant (87%), with 7% electrons
- Secondary particle distribution:
  - Detector plane: tangent to the outer wall of the beam pipe,  $\pm 31$  mm in horizontal, detector mounting plane
  - Statistical distribution of secondary particles in the detector plane
  - Vertical distribution: symmetrical distribution with respect to the origin
  - Beam direction: 23 cm (Position 1) and 17 cm (Position 3) from one end of the primary electron loss region





N<sub>sp</sub>/N<sub>total</sub>(%) at Position 3

-31 mm detector plane

86.93

7.80

5.27S

100

N<sub>sp</sub>/N<sub>total</sub>(%) at Position 1

87.67

7.32

5.01

100

87.86

7.19

4.95

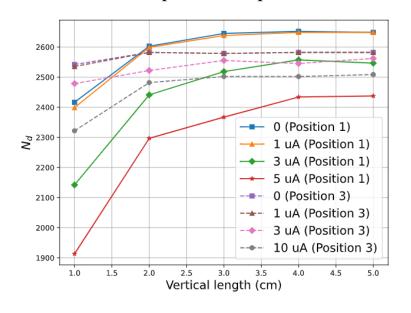
100

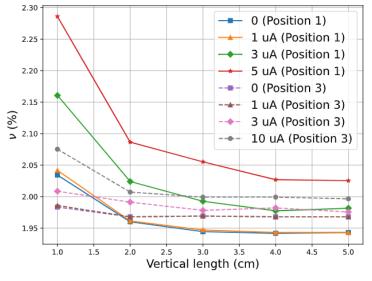
Secondary particle species -31 mm detector plane

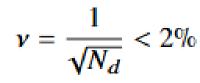
others

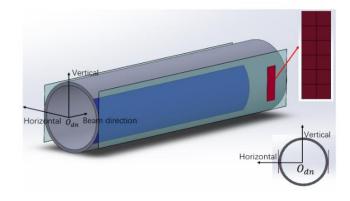
total

- Fast luminosity detector 2% precision requirement:
  - 804 bunch crossing within 1 ms, bunch space: 600 ns (Low power Higgs mode)
  - Average 3.4 and 3.2 particles interact with the beam pipe at position 1 and position 3 per bunch crossing, respectively. (Poisson distribution)
  - Precision  $v \le 2\%$ , the number of detected Bhabha electrons  $N_d \ge 2500$  (within 1 ms)
- Detector dimension optimization:
  - The entire detector is constructed by  $5 \text{mm} \times 5 \text{mm}$  pixels
  - The detector length in the beam-direction is fixed at 1 cm, while the vertical length varies
  - Different equivalent input current noise levels (0, 1uA, 3uA, 5uA, 10uA) are considered



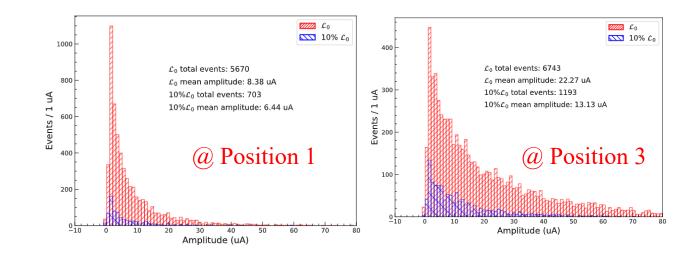


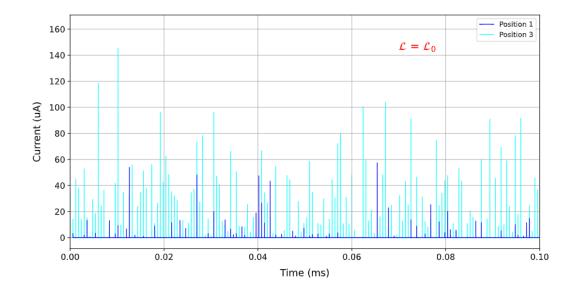


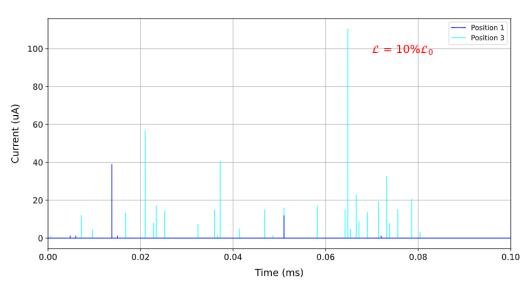


- The final determined detector dimension is 1 cm (beam direction) × 3 cm (vertical length), 12 pixels in total.
- The noise threshold at position 1 is 3  $\mu$ A, while the noise threshold at position 3 is 10  $\mu$ A.

- Luminosity fluctuation → detector' response change
  - For a single pixel, different signal responses at nominal luminosity and 10% of nominal luminosity
  - For the entire detector, significant differences in the number and amplitude of the signals.

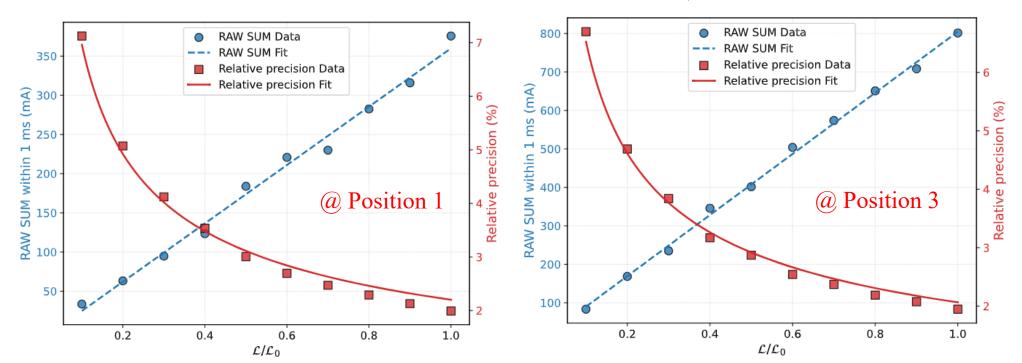






- The relationship between detector RAW SUM and luminosity
  - Assuming the sampling frequency of the DAQ is 10 GHz
  - Define RAW SUM:
    - s signifies the sampling points within 1 ms
    - p denotes the channel associated with each pixel within the single-sided detector
    - *j* represents the signals generated by the detectors situated on both sides of the beam pipe at Position 1
- The relative precision under different luminosity conforms to  $v \propto \frac{1}{\sqrt{L}}$

RAW SUM = 
$$\sum_{j=1}^{2} \sum_{s \in \mathcal{S}} \sum_{p \in \mathcal{P}} i_j(s, p)$$
 at Position 1  
RAW SUM =  $\sum_{s \in \mathcal{S}} \sum_{p \in \mathcal{P}} i_j(s, p)$  at Position 3



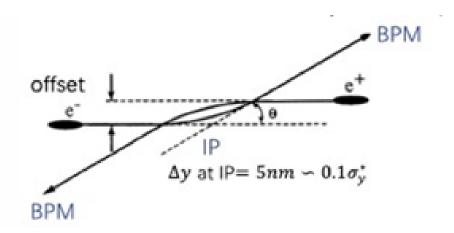
## Beam-Beam Deflection and Background Concerns for CEPC Fast Luminosity Detector

- Beam-Beam Deflection:
  - originates from the electromagnetic interaction between the electron and positron bunches
  - the principle of BPM measurement of the orbit offset
- Beam-Beam Deflection mainly impacts position 1, with almost no effect on position 3
- 10% reduction of detected Bhabha electrons after considering beam-beam deflection(the worst case)
- After considering beam-beam deflection, the detector precision  $v_b$  becomes 1.04v

$$(\frac{N_w}{N_{wo}})_{max} = 90\%$$

$$V_b = \frac{1}{\sqrt{N_b}},$$

$$N_b = \frac{N_w}{N_{wo}} \times N_d$$



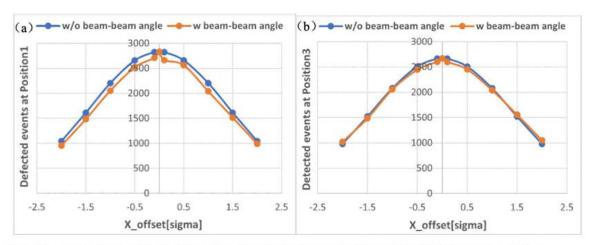


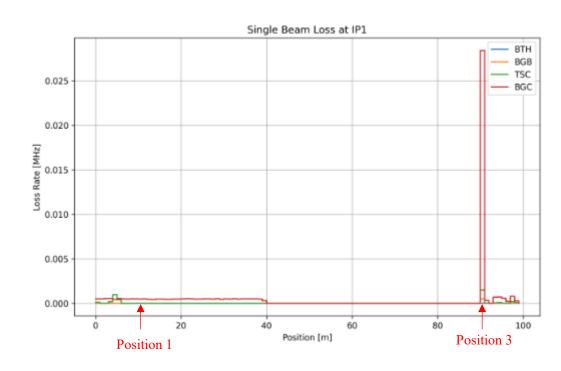
Fig. 12 Expected detected Bhabha events varies with IP offset at Positions 1 and 3

## Beam-Beam Deflection and Background Concerns for CEPC Fast Luminosity Detector

#### Single-Beam background:

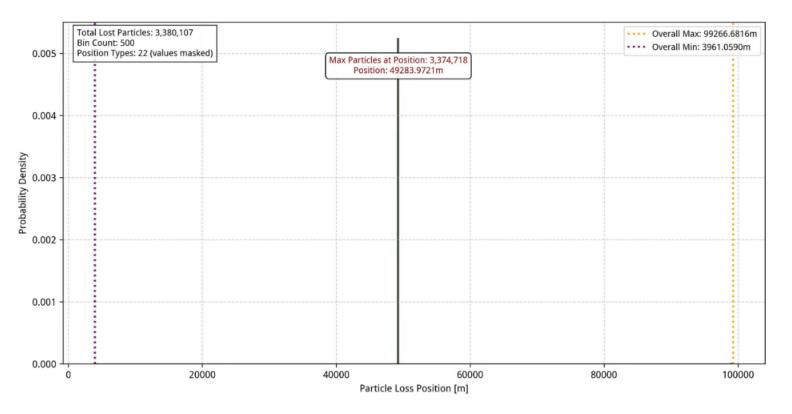
- 4 single-beam background are concerned: beam-thermal photon scattering (BTH), beam-gas scattering (Coulomb scattering (BGC) and Bremsstrahlung scattering (BGB)), and Touschek scattering (TSC)
- BGC dominants, and the single-beam background has losses at position 1 and position 3

	Single-Beam background	Primary electrons by radiative Bhabha
Position 1	7×10 <sup>-5</sup> per bunch crossing	3.4 per bunch crossing
Position 3	2×10 <sup>-2</sup> per bunch crossing	3.2 per bunch crossing



#### Beam-Beam Deflection and Background Concerns for CEPC Fast Luminosity Detector

- Injection background:
  - Top-up injection
  - Aperture blocks to minimize the impact of injection background on the collision region
  - With beam-beam impact concerned
  - 50 million particles are injected and run around the ring for 200 turns
- Particle loss is mainly concentrated at 49.28 km downstream of the IP, with no loss at position 1 and Position 3(10 m and 90.5 m downstream of the IP)



#### Conclusion and Next to do

#### Conclusion:

- The dimension (1 cm × 3 cm) and position (Position 1 offset 23 cm, Position 3 offset 17 cm) of the detector installation have been determined.
- Detector RAW SUM within 1 ms has a good linear relationship with luminosity, and therefore can be used for real-time luminosity monitoring.
- The impact of Beam-Beam deflection, Single-beam background and Injection background has been concerned

#### • Next to do:

- 4H-SiC device fabrication and test
- Design for multi-channel ultrafast readout electronics of the detector
- A fast luminosity monitor system prototype and Design validation at BEPCII

# Thanks